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Atty. Dkt. No. 059277-0126

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Applicant: Yoko HIROHARA et al.  
Title: EYE CHARACTERISTICS MEASURING SYSTEM  
Appl. No.: 10/529,150  
Filing Date: 9/25/2003  
Examiner: Mohammed A. Hasan  
Art Unit: 2873  
Confirmation Number: 2078

**STATEMENT OF SUBSTANCE OF INTERVIEW**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

In accordance to 37 C.F.R. § 1.133, submitted herewith is a record of the substance of the interview on September 22, 2008, between Examiner Mohammed A. Hasan and Pavan K. Agarwal, regarding the above-captioned application. This statement is being submitted within one (1) month of the mailing date of October 8, 2008, of the Interview Summary and is therefore a timely response. The contents of the Interview Summary are correct.

Respectfully submitted,

Date October 17, 2008

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By 

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